

1/4-Inch CMOS Active Pixel Sensor with Smart On-Chip Functions and Full Digital Interface

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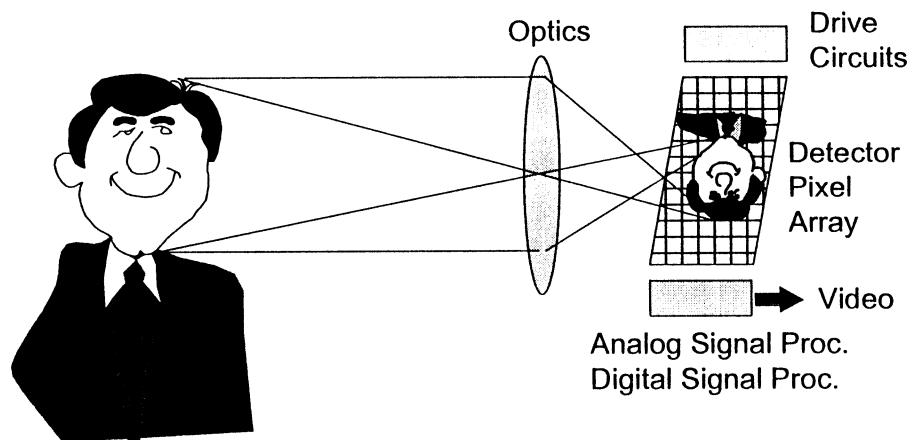
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Part I.

Brief Introduction to CMOS Image Sensors

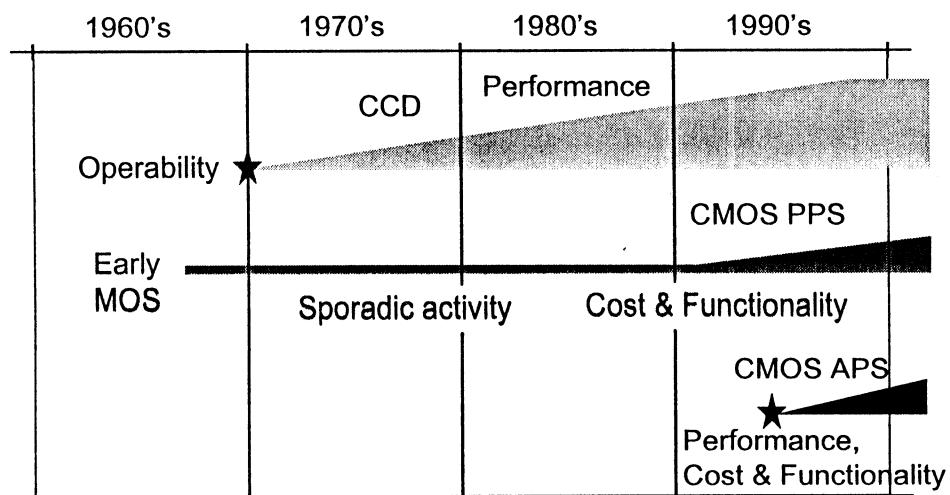
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IMAGING SYSTEMS



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TIMELINE



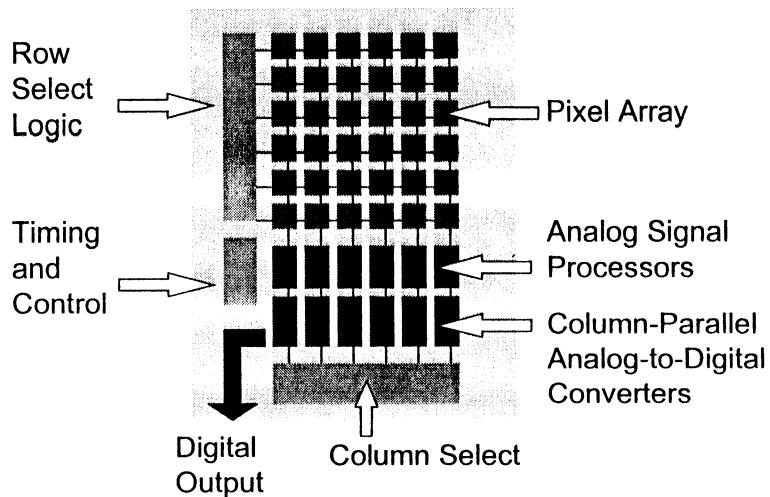
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CCD LIMITATIONS

- Requires high charge transfer efficiency
 - Special fabrication process
 - Large voltage swings, different voltage levels
- Difficult to integrate on-chip timing, control, drive and signal chain electronics
- Serial access to image data
- System power in 1-10 Watt range

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CMOS IMAGE SENSOR ARCHITECTURE



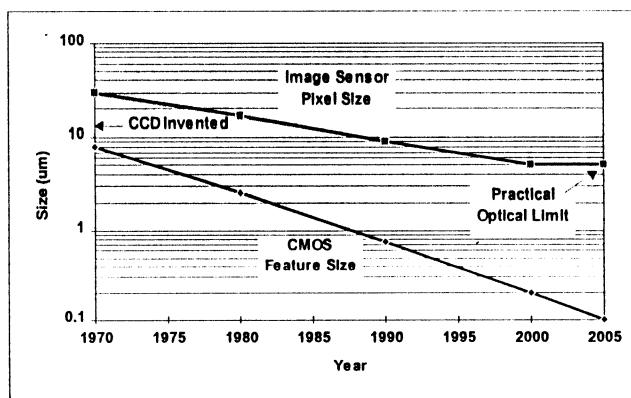
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TIMING IS EVERYTHING

- CMOS state of the art is ripe for image sensors
 - Design rules permit competitive pixel sizes
 - Defects and contamination well controlled
 - Threshold voltages stable and fairly uniform
- Customers demand low power, miniaturized systems-on-a-chip
- Circuit techniques developed for high performance
 - Active pixel provides gain in pixel
 - Column parallel architecture permits low analog bandwidths to reduce noise and artifacts.
 - Use of double-correlated sampling and double-delta sampling on-chip removes temporal & fixed pattern noise

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EVOLUTION OF FEATURE SIZE

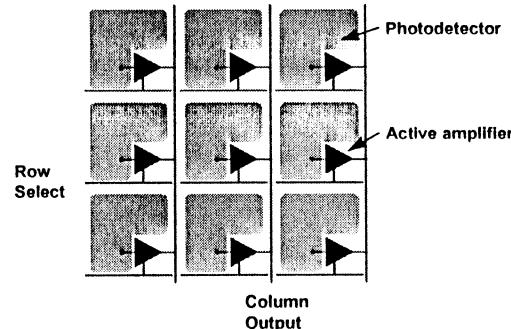


- Enough space to put amplifier into each pixel.

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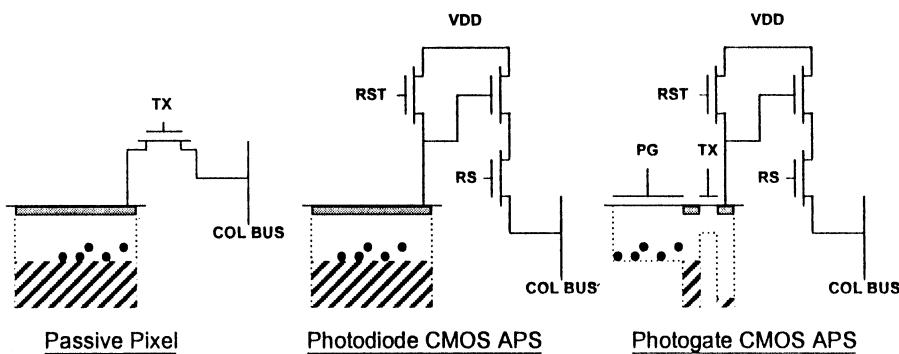
ACTIVE PIXEL

- Each pixel has its own output amplifier
- Pixels are X-Y addressed
- Key is low noise readout circuit
- Best of CCD detection/readout and CMOS integration



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COMMON CMOS PIXELS



Passive Pixel

- 1 transistor pixel
- 10 L scaling
- Great QE
- Poor noise (250 e-)
- Poor scaling for large arrays
- Poor for fast readout

Photodiode CMOS APS

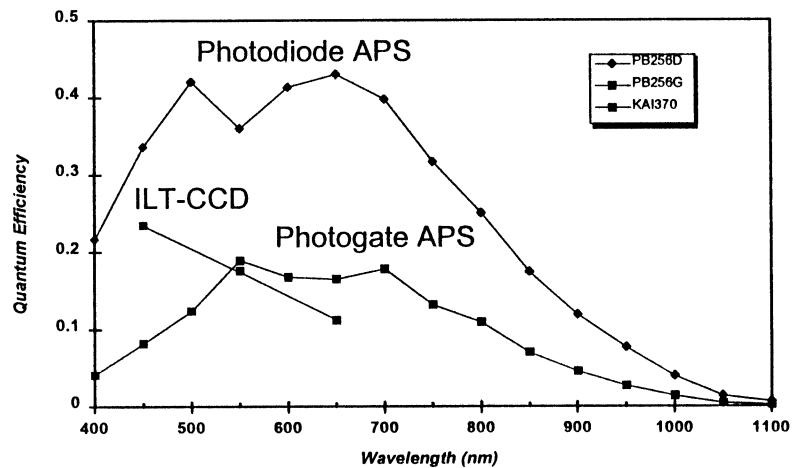
- 3 transistor pixel
- 15 L scaling
- Great QE
- OK noise (50-100 e-)
- Good for large arrays
- Good for fast readout

Photogate CMOS APS

- 5 transistor pixel
- 20 L scaling
- Good QE
- Great noise (15 e-)
- Good for large arrays
- Good for fast readout

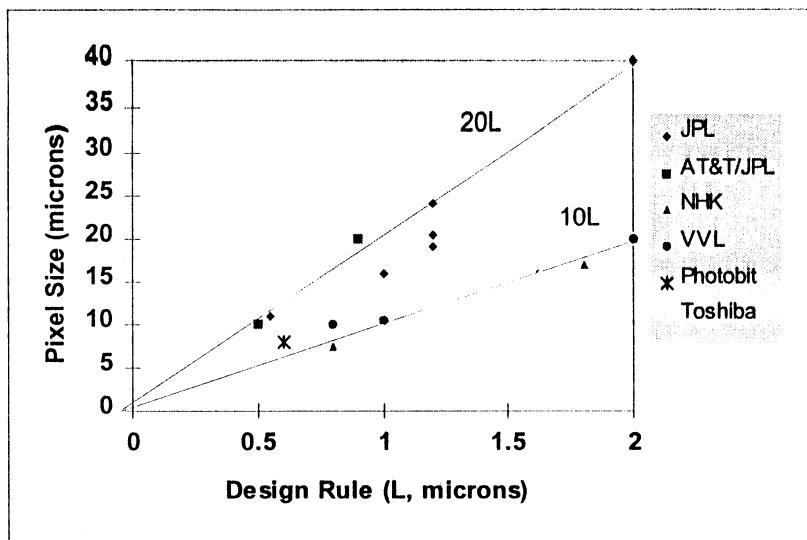
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APS QUANTUM EFFICIENCY



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SCALING TREND



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ON-CHIP ADC

- Permits full digital interface
- Permits on-chip DSP for camera control, color interpolation, etc.
- Suppresses noise pick up from EMI, crosstalk
- Simplifies interface
- Permits faster readout
- Can reduce overall chip power

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ON-CHIP ADC CHOICES

- One (or two or three) ADCs per chip
 - High data rate requirement (5-60 Mconv/s)
 - Local high power dissipation
- One ADC per pixel
 - Large pixels and low fill factor
- One ADC per column (column-parallel)
 - Tall, skinny ADCs



- Single-slope
 - slow
- Successive approximation
 - 8-10 b max
- Algorithmic
 - needs op-amp
- Oversampled
 - Filter takes lots of area
- Flash
 - Lots of power

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PB256E

- 256x256 Element PD-APS
- 256 Column-parallel ADCs
- 8b Resolution
- On-chip FPN suppression
- 30 frames per second
- Under 50 mW total power
- Note lack of blooming or other artifacts



Panicacci 1996

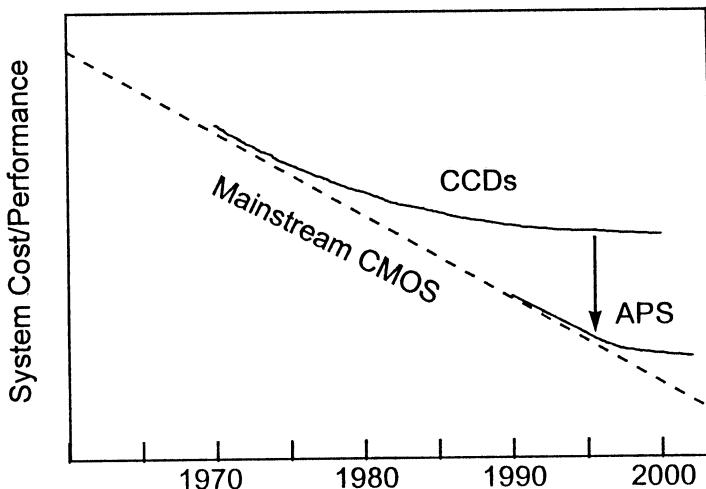
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ADVANTAGES OF CMOS APS

- Maintains high performance of CCD sensors
 - high sensitivity, low noise, wide dynamic range
 - no smear, no blooming, no lag
- 100 x less system power than comparable CCD system
 - 10-50 milliWatts instead of 1-5 Watts
 - single 5V (3.3V) supply, full digital interface
- 10 x less camera volume than comparable CCD system
 - on-chip integration of timing, control, ADC functions
- 2 x less cost
 - fewer components, simple module assembly
- Unique functional advantages
 - Window of interest readout for electronic pan, tilt, zoom.
 - Ultra wide intrascene dynamic range
 - On-chip DSP and sensor control functions (e.g. AGC)

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DISCUSSION



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Part II.

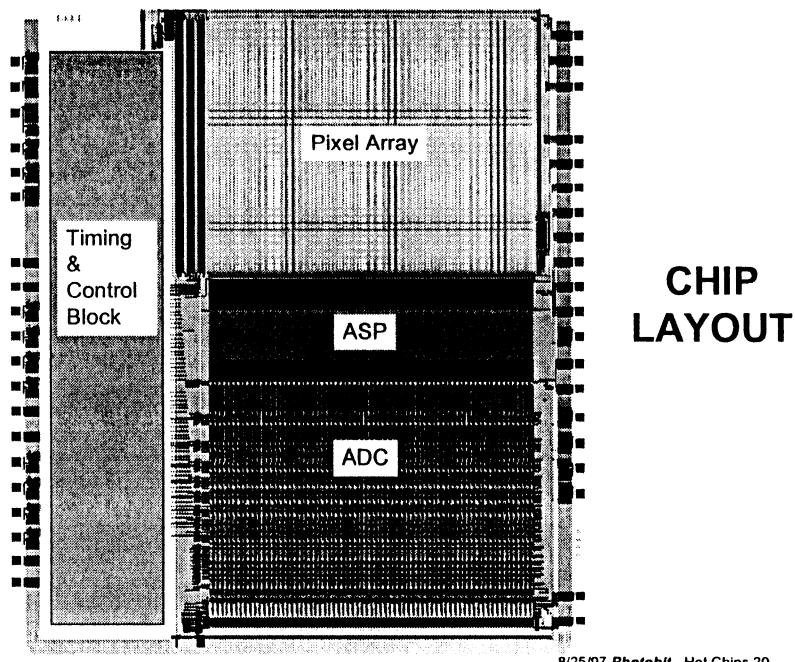
**1/4-Inch CMOS APS
with On-Chip Smart Functions
and Full Digital Interface
(PB159)**

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STATUS

- Sensor is in fabrication (7/7/97).

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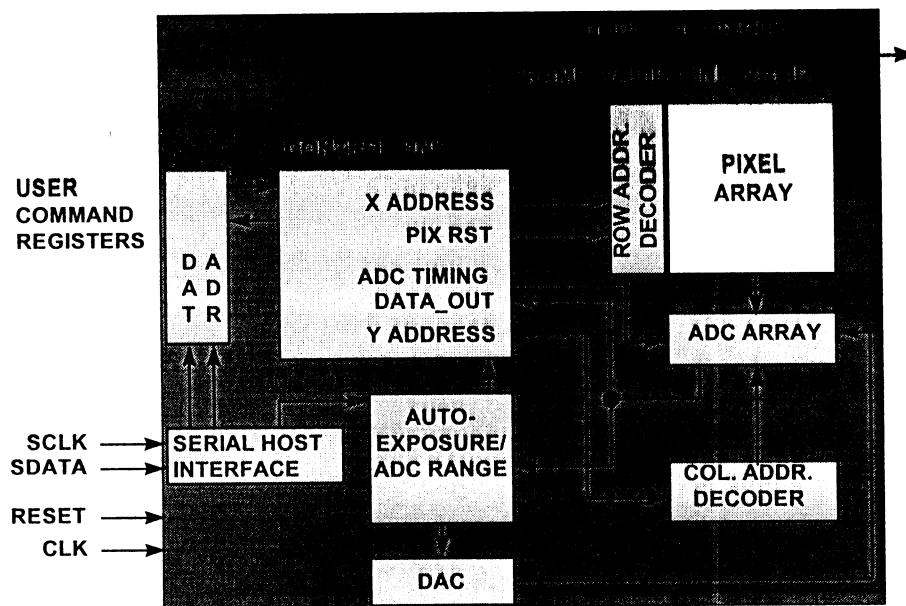
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CHIP SPECIFICATIONS

Total Effective Pixels : 196,608 (512 x 384)
Pixel Size : 7.9 μm x 7.9 μm photo-diode
Shutter : electronic rolling snap
CDS : on chip
ADC : on chip 8 bit column parallel
Output : 8 bit color digital video
Data rate : 14.3 Mbytes/s
Auto Exposure : on chip with manual user override
Package : 40 pins
Timing and Control : on chip controller with 14.3 MHz master clock
Power : 40 - 50 mW
Programmable features : window size and location
exposure
ADC reference
frame rate
ADC test mode
readable chip internal registers for test
auto exposure parameters (update rate, thresholds)
on command ADC calibration

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SENSOR BLOCK DIAGRAM



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FEATURES

- Default power up state does not require user to program the device in order to get continuous video (default setting produces 512 x 384 window at a 30 Hz frame rate with auto exposure enabled).
- Industry standard serial interface to load user commands (Sensor has 2 hardware selectable device addresses so that other devices can share the serial bus including another APS sensor).
- Auto exposure settings includes a disable for manual exposure control. Hold current exposure command also available for auto-exposure.

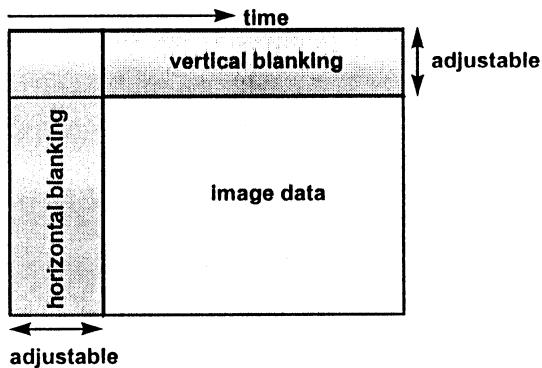
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FEATURES (cont.)

- Adjustable frame rate (3-40 Hz)
- Sensor chip enable register allows user to pause imager (no integration).
- Low power standby pin available to turn off DC power consumption (10 mW residual AC power from 14.3 MHz clock component)
- Simple user interface has a master clock, 2 signals for serial interface, 8 data outputs, 4-5 bias pins (1.2V, 2.5V, 1V), VDD(5V), and GND(0V). External biases generated with simple resistor divider between VDD and GND.

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OUTPUT DATA FORMAT



- 8 bit digital image data with embedded sync's (pseudo CCIR-656)
- data control codes requires FF, 00 image data to be mapped to FE, 01
- frame valid, line valid sync output pins also available

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SUMMARY

- CMOS APS technology permits high performance imaging with standard CMOS.
- A new 1/4-inch CMOS APS with smart on-chip functions and full digital interface has been introduced.

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